Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,297	WANG ET AL.	
Examiner	Art Unit	
Jafar Parsa	1621	

1	SEAR	CHED	
Class	Subclass	Date	Examiner
518	700	12/9/2005	JP
518	704	12/9/2005	JP
518	712	12/9/2005	JP
518	713	12/9/2005	JP
518	714	12/9/2005	JP
518	715	12/9/2005	JP
518	719	12/9/2005	JP

INT	ERFERENC	E SEARCH	HED
Class	Subclass	Date	Examiner
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East, West and STN  INVENTOR NAME SEARCH	DATE  12/7/2005	JP JP
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